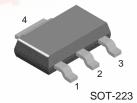


NZT605

NPN Darlington Transistor

- This device designed for applications requiring extremely high gain at collector currents to 1.0A and high breakdown voltage. WWW.DZSG.C
- Sourced from process 06.



1. Base 2.4. Collector 3. Emitter

Absolute Maximum Ratings T_C=25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V _{CEO}	Collector-Emitter Voltage	110	V	
V _{CBO}	Collector-Base Voltage	140	V	
V _{EBO}	Emitter-Base Voltage	10	V	
I _C	Collector Current - Continuous	1.5	Α	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	- 55 ~ +150	°C	

^{*} These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

These ratings are baseed on a maximum junction temperature of 150 degrees C.
 These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Electrical Characteristics T_C=25°C unless otherwise noted

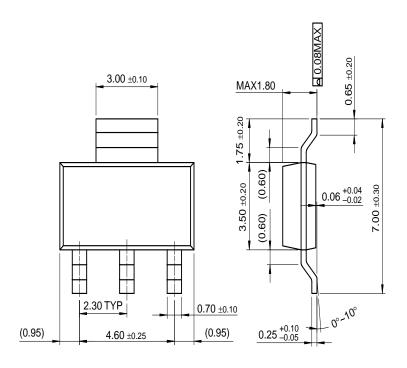
Symbol	Parameter	Test Conditions	Min.	Max.	Units
Off Characte	eristics				
V _{(BR)CEO}	Collector-Emitter Breakdown Voltage *	$I_C = 10 \text{mA}, I_B = 0$	110		V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_{C} = 100\mu\text{A}, I_{E} = 0$	140		V
V _{(BR)EBO}	Emitter-Base Breakdown Voltage	$I_E = 100\mu A, I_C = 0$	10		V
I _{CBO}	Collector Cutoff Current	$V_{CB} = 120V, I_{E} = 0$		10	nA
I _{CES}	Collector Cutoff Current	$V_{CE} = 120V, I_{E} = 0$		10	nA
I _{EBO}	Emitter Cutoff Current	$V_{EB} = 8.0V, I_{C} = 0$		100	nA
On Characte	eristics *				
h _{FE}	DC Current Gain	$I_C = 50 \text{mA}, V_{CE} = 5.0 \text{V}$ $I_C = 500 \text{mA}, V_{CE} = 5.0 \text{V}$ $I_C = 1.0 \text{A}, V_{CE} = 5.0 \text{V}$ $I_C = 2.0 \text{A}, V_{CE} = 5.0 \text{V}$ $I_C = 2.0 \text{A}, V_{CE} = 5.0 \text{V}$	2000 5000 2000 500	100K	C.C
V _{CE(sat)}	Collector-Emitter Saturation Voltage	$I_C = 250 \text{mA}, I_B = 0.25 \text{mA}$ $I_C = 1.0 \text{A}, I_B = 1.0 \text{mA}$		1 1.5	V
V _{BE(sat)}	Base-Emitter Saturation Voltage	I _C = 1.0A, I _B = 1.0mA		1.8	V
V _{BE(on)}	Base-Emitter On Voltage	$I_C = 1.0A, V_{CE} = 5.0V$		1.7	V
	I Characteristics				
f _T	Transition Frequency	I _C = 100mA, V _{CE} = 10V, f = 20MHz	150		MHz

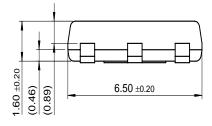
Thermal Characteristics T_A=25°C unless otherwise noted

Symbol	Parameter	Max.	Units
P _D	Total Device Dissipation	1,000	mW
	Derate above 25°C	8.0	mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	125	°C/W
Device mounted on FR-4 PCB 36mm × 18mm × 1.5mm; mounting pad for the collector lead min, 6cm ²			

Package Dimensions

SOT-223





Dimensions in Millimeters

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The Power Franchise™		OPTOLOGIC [®]	SILENT SWITCHER®	VCX™
Programmable Ad	ctive Droop™	OPTOPLANAR™	SMART START™	

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PRODUCT STATUS DEFINITIONS

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